Search Notes

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/551,623	OSHIMA ET AL.	
	Examiner	Art Unit	
_	Chuck Mah	3677	

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Class	Subclass	Date	Examiner
16	369		
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	330		
379	433.12		
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455	575.1	575.4	
	575.3	515.8	
	550.1	70.3	
361	814,		
	680-68	3	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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